

<b>Notice of References Cited</b>		Application/Control No. 09/680,041	Applicant(s)/Patent Under Reexamination TAY, HIOK-NAM	
		Examiner Yogesh K Aggarwal	Art Unit 2615	Page 1 of 1

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B	US-6,275,191	08-2001	Lesea et al.	343/700MS
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**NON-PATENT DOCUMENTS**

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